

### General Description

The AO4466 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

\* RoHS and Halogen-Free Compliant

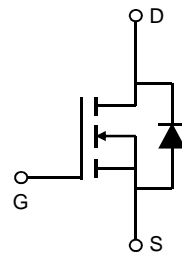
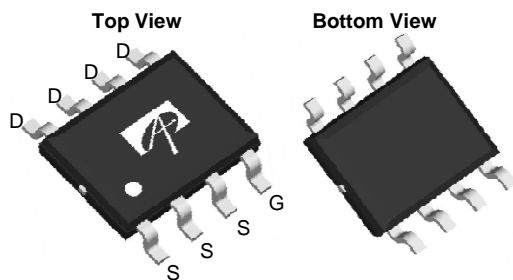
### Product Summary

$V_{DS} (V) = 30V$   
 $I_D = 10A$  ( $V_{GS} = 10V$ )  
 $R_{DS(ON)} < 23m\Omega$  ( $V_{GS} = 10V$ )  
 $R_{DS(ON)} < 35m\Omega$  ( $V_{GS} = 4.5V$ )

100% UIS Tested  
 100% Rg Tested



SOIC-8



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter   | Symbol         | Maximum          | Units      |
|---|----------------|------------------|------------|
| Drain-Source Voltage                              | $V_{DS}$       | 30               | V          |
| Gate-Source Voltage                               | $V_{GS}$       | $\pm 20$         | V          |
| Continuous Drain Current <sup>AF</sup>            | $I_D$          | 10               | A          |
|   |                | $T_A=70^\circ C$ |            |
| Pulsed Drain Current <sup>B</sup>                 | $I_{DM}$       | 64               |            |
| Power Dissipation                                 | $P_D$          | 3.1              | W          |
|   |                | $T_A=70^\circ C$ |            |
| Avalanche Current <sup>B, G</sup>                 | $I_{AR}$       | 12               | A          |
| Repetitive avalanche energy 0.1mH <sup>B, G</sup> | $E_{AR}$       | 7                | mJ         |
| Junction and Storage Temperature Range            | $T_J, T_{STG}$ | -55 to 150       | $^\circ C$ |

### Thermal Characteristics

| Parameter                                | Symbol          | Typ          | Max | Units        |
|--|-----------------|--------------|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 36           | 40  | $^\circ C/W$ |
|  |                 | Steady-State | 62  |              |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 18           | 24  | $^\circ C/W$ |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min | Typ          | Max      | Units |
|-----------------------------|---------------------------------------|---|-----|--------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |              |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 30  |              |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30 V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                           |     |              | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V   |     |              | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                    | 1.5 | 2.1          | 2.6      | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V  | 64  |              |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =10A<br>T <sub>J</sub> =125°C                        |     | 16.7<br>24.3 | 23<br>30 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =5A   |     | 23.7         | 35       |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =10A  |     | 17           |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |     | 0.75         | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |     |              | 2.4      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |              |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz   | 298 | 373          | 448      | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   | 46  | 67           | 88       | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |   | 24  | 41           | 58       | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  | 0.6 | 1.8          | 2.8      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |              |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =10A                           | 5.7 | 7.1          | 8.6      | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |   | 2.7 | 3.5          | 4.2      | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |     | 1.2          |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |     | 1.6          |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.5Ω,<br>R <sub>GEN</sub> =3Ω |     | 4.3          |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |     | 2.8          |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |     | 15.8         |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |     | 3            |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =10A, dI/dt=100A/μs  | 8.4 | 10.5         | 12.6     | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =10A, dI/dt=100A/μs  | 3.6 | 4.5          | 5.4      | nC    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =10A, dI/dt=500A/μs  | 4.7 | 6.0          | 7.2      | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =10A, dI/dt=500A/μs  | 5.3 | 6.6          | 8        | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The SOA curve provides a single pulse rating.

F: The current rating is based on the t ≤ 10s junction to ambient thermal resistance rating.

G: L=100uH, V<sub>DD</sub>=0V, R<sub>G</sub>=0Ω, rated V<sub>DS</sub>=30V and V<sub>GS</sub>=10V

Rev 9: May. 2012

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

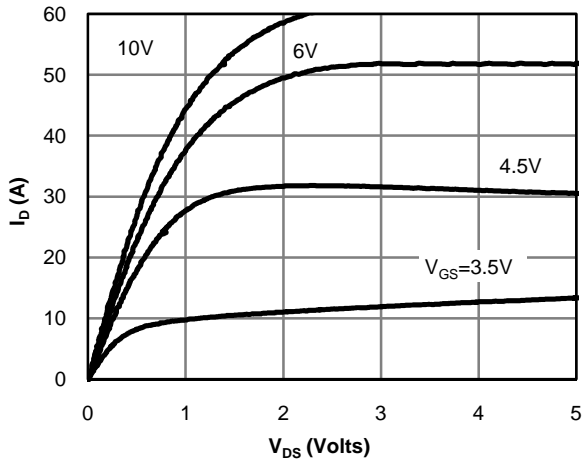


Fig 1: On-Region Characteristics

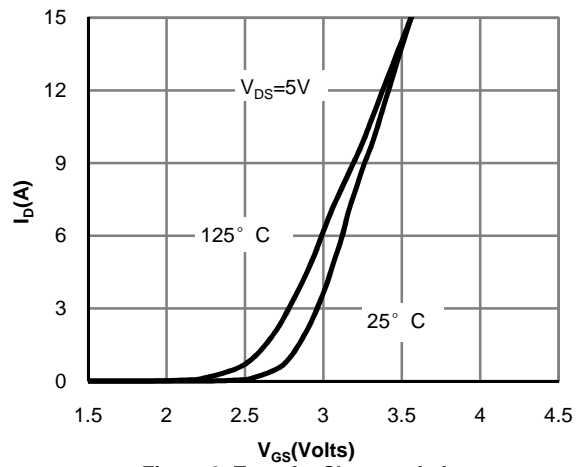


Figure 2: Transfer Characteristics

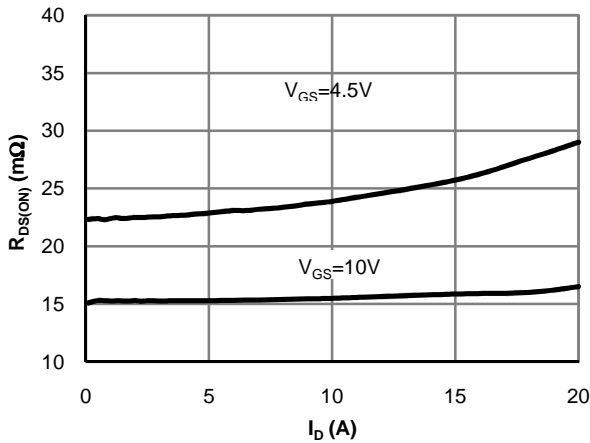


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

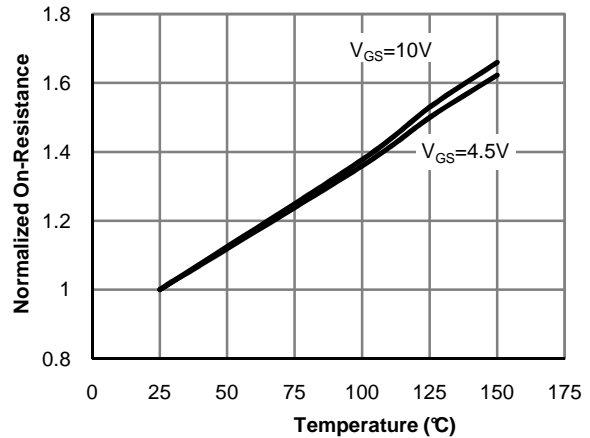


Figure 4: On-Resistance vs. Junction Temperature

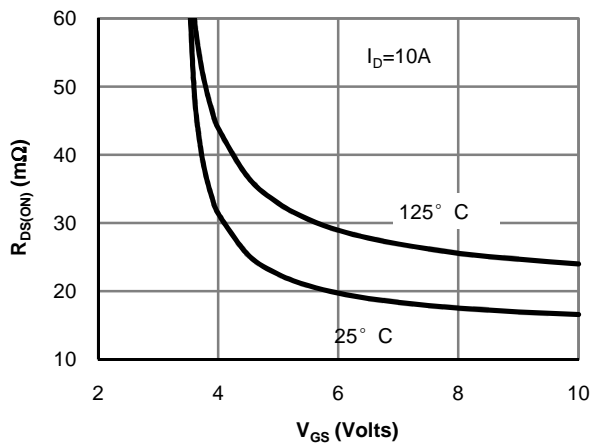


Figure 5: On-Resistance vs. Gate-Source Voltage

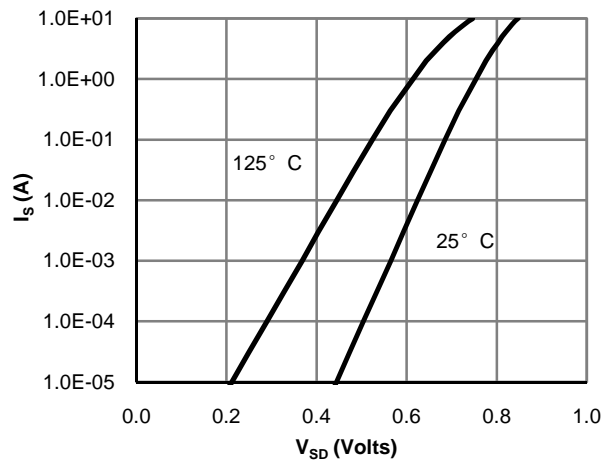


Figure 6: Body-Diode Characteristics

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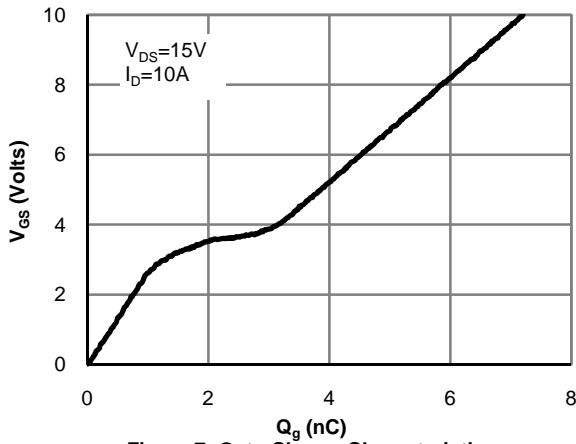


Figure 7: Gate-Charge Characteristics

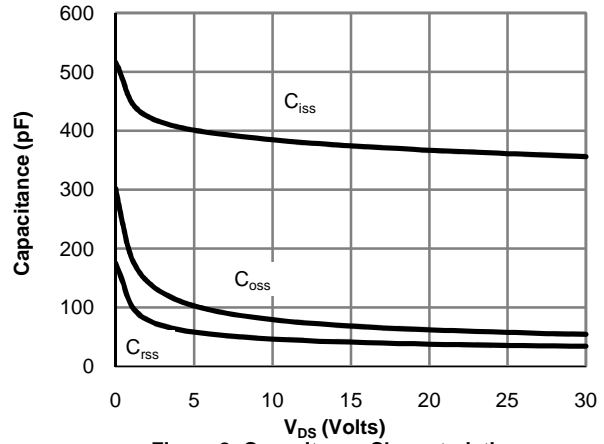


Figure 8: Capacitance Characteristics

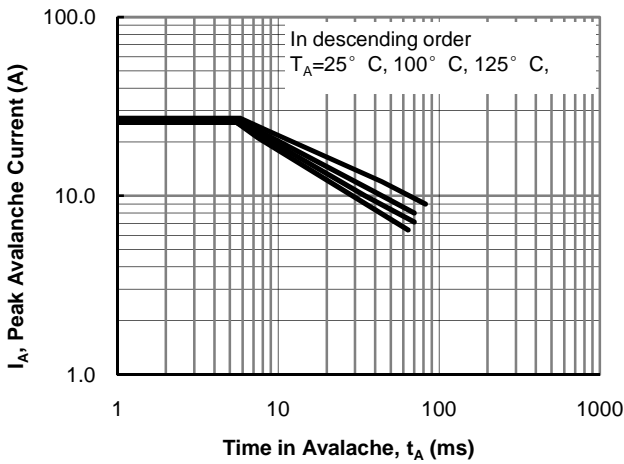


Figure 9: Single Pulse Avalanche Capability

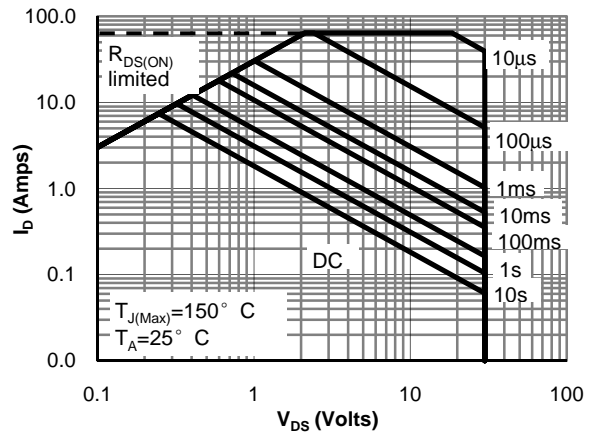


Figure 10: Maximum Forward Biased Safe Operating Area (Note E)

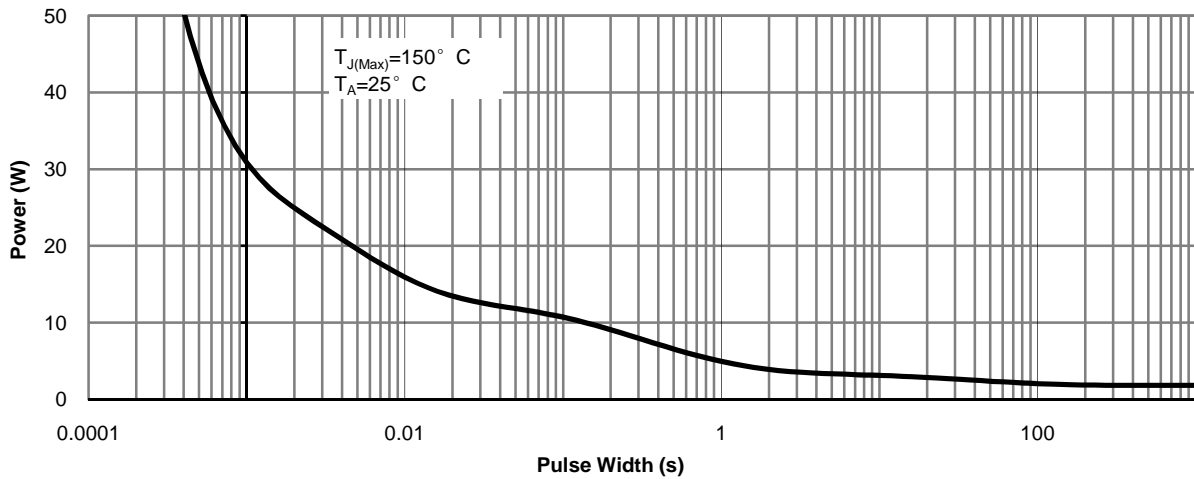
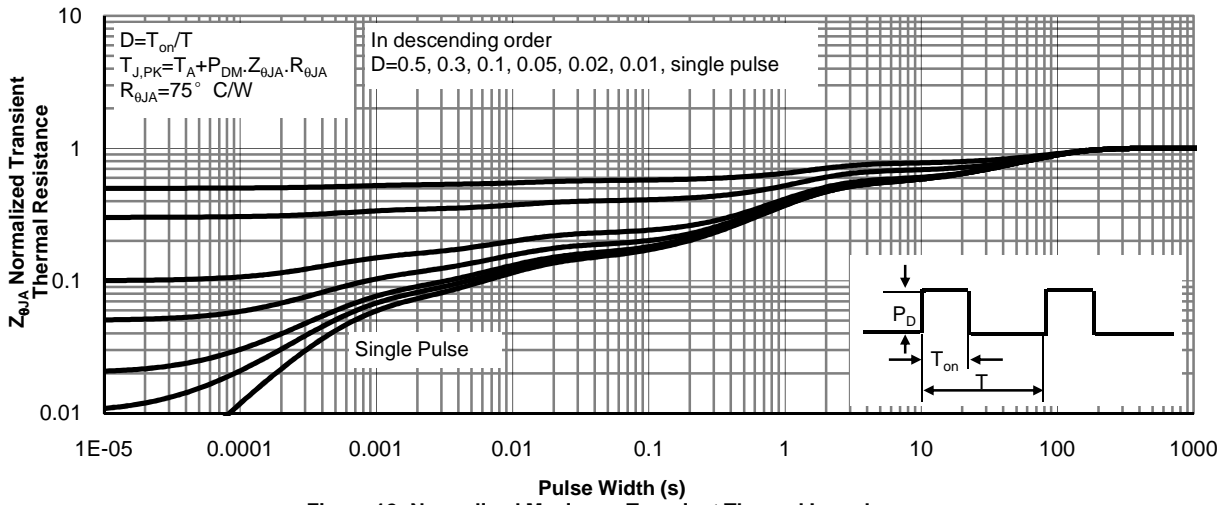
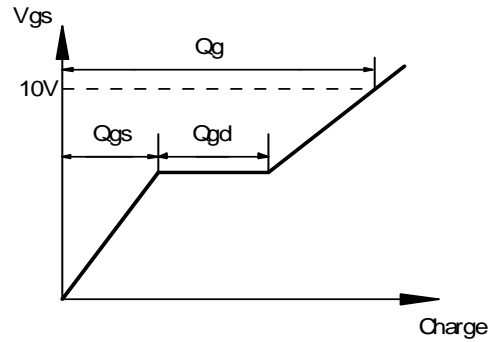
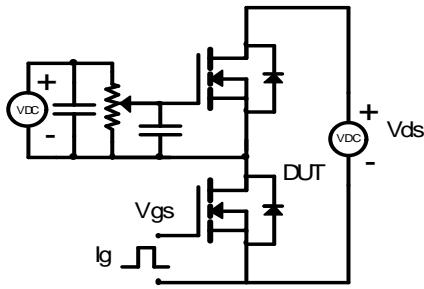


Figure 11: Single Pulse Power Rating Junction-to-Ambient (Note E)

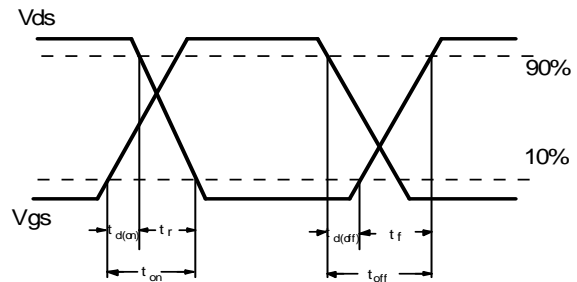
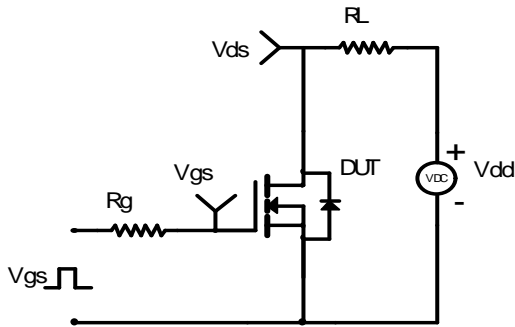
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



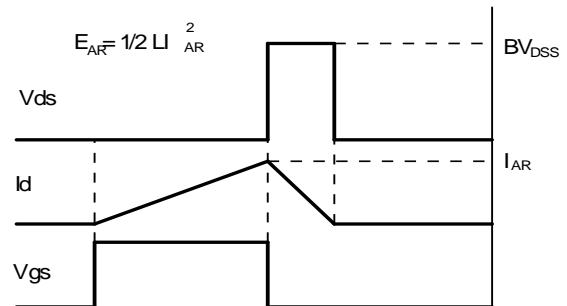
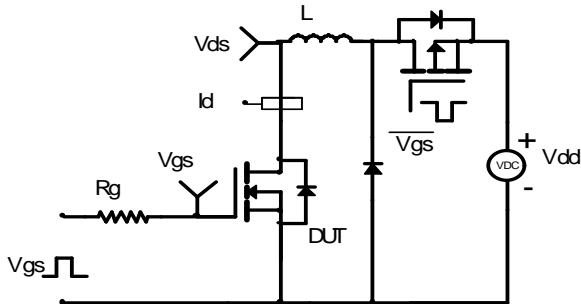
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

